Applicati n/Contr I N .	Applicant(s)/Patent under Re xamination
09/971,080	SHAH, HITESH
Examiner	Art Unit
Michael T. Thier	2617

SEARCHED					
Class	Subclass	Date	Examiner		
See	prior				
searchs					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
-				
	<u> </u>			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated search. See attached EAST search.	7/14/2006	MTT
Spoke with Duc Nguyen.	7/14/2006	MTT